

CE EMC TEST REPORT

for

Product:Sound Level Meter
Model:HT622A,HT622B
Report No.: PTC19081204003E-EM01

Issued for

Dongguan Habotest Instrument Technology Co., Ltd.

3/F, Building A, No.7 Liangtouwei Street, Liheng Village, Qingxi Town,
Dongguan, China

Issued by

Dongguan Precise Testing & Certification Corp., Ltd.

Building 1, No. 6, Tongxin Road, Dongcheng Street, Dongguan, Guangdong,
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TABLE OF CONTENTS

1. TEST CERTIFICATION	3
2. TEST SUMMARY	4
3. TEST SITE.	
3.1. TEST FACILITY	
3.2. MEASUREMENT UNCERTAINTY	
3.3. LIST OF TEST AND MEASUREMENT INSTRUMENTS	6
4. EUT DESCRIPTION	
5. TEST METHODOLOGY	11
5.1. TEST MODE	
5.2. EUT SYSTEM OPERATION	11
6. SETUP OF EQUIPMENT UNDER TEST	
6.1. DESCRIPTION OF SUPPORT UNITS	12
6.2. CONFIGURATION OF SYSTEM UNDER TEST	
7. EMISSION TEST	
7.1. CONDUCTED EMISSION MEASUREMENT	13
7.2. RADIATED EMISSION MEASUREMENT	
7.3. HARMONICS CURRENT MEASUREMENT	19
7.4. VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT	21
8. IMMUNITY TEST	22
8.1. GENERAL DESCRIPTION	
8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION	23
8.3. ELECTROSTATIC DISCHARGE (ESD)	24
8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)	28
8.5. ELECTRICAL FAST TRANSIENT (EFT)	31
8.6. SURGE IMMUNITY TEST	32
8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)	
8.8. POWER FREQUENCY MAGNETIC FIELD	
8.9. VOLTAGE DIP & VOLTAGE INTERRUPTIONS	
9. PHOTOGRAPHS OF THE TEST CONFIGURATION	40
10. PHOTOGRAPHS OF EUT	42



1. TEST CERTIFICATION

Product: Sound Level Meter Model: HT622A,HT622B

Applicant: Dongguan Habotest Instrument Technology Co., Ltd.

Address: 3/F, Building A, No.7 Liangtouwei Street, Liheng Village, Qingxi Town,

Dongguainan, Ch

Manufacturer: Dongguan Habotest Instrument Technology Co., Ltd.

Address: 3/F, Building A, No.7 Liangtouwei Street, Liheng Village, Qingxi Town,

Dongguan, China

Test Date: Aug. 14, 2019 to Aug. 22, 2019

Issued Date: Aug. 22, 2019

Test Voltage: Battery

Applicable EMC Directive 2014/30/EU

Standards: EN 61326-1: 2013

EN 61326-2-2:2013 EN 61000-3-2: 2014 EN 61000-3-3: 2013

The above equipment has been tested by Dongguan Precise Testing & Certification Corp., Ltd. and found compliance with the requirements in the technical standards mentioned above. The test results presented in this report only relate to the product/system tested. The Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Test Engineer.

Technical Manager.





2. TEST SUMMARY

EMISSION					
Standard	Item	Result	Remarks		
EN 61326-1: 2013	Conducted emission (Mains Port)	N/A	Not applicable		
5, 5, 6, 6, 6, 6, 6, 6	Radiated emission	PASS	Meet Class B limit		
EN 61000-3-2: 2014	Harmonic current emissions	N/A	Not applicable		
EN 61000-3-3: 2013	Voltage fluctuations & flicker	N/A	Not applicable		

IMMUNITY					
Standard	Standard Item		Remarks		
EN 61000-4-2:2009	ESD	PASS	Complied with the requirements		
EN 61000-4-3:2006+ A1:2008+A2:2010	RS	PASS	Complied with the requirements		
EN 61000-4-4:2012	ÉFT?	N/A	Not applicable		
EN 61000-4-5:2014	Surge	N/A	Not applicable		
EN 61000-4-6:2014	CS	N/A	Not applicable		
EN 61000-4-8:2010	PFMF	N/A	Not applicable		
EN 61000-4-11:2004	Voltage dips & voltage variations	N/A	Not applicable		

Note: 1) The test result verdict is decided by the limit of test standard.

²⁾ The information of measurement uncertainty is available upon the customer's request.



3. TEST SITE

3.1. TEST FACILITY

Dongguan Precise Testing & Certification Corp., Ltd.

Address: Building 1, No. 6, Tongxin Road, Dongcheng Street, Dongguan, Guangdong, China.

☆ CNAS Registration No.: CNAS L5772

☆ FCC Registration No.: 790290
 ☆ A2LA Certificate No.: 4408.01
 ☆ IC Registration No.: 12191A-1

Test Lab: Guangdong Dongguan Quality Supervision Testing Center

Address: No. 2, Industrial South Road, Songshan Lake Science and Technology

Industrial Park, Dongguan City, China

Test items: radio frequency electromagnetic field immunity (R/S) test

3.2. MEASUREMENT UNCERTAINTY

Parameter	Uncertainty
Temperature	±1° C
Humidity	±5%
DC and Low Frequency Voltages	±3%
Conducted Emission(150KHz-30MHz)	±3.60dB
Radiated Emission(30MHz-1GHz)	±4.76dB
Radiated Emission (1GHz-18GHz)	±4.44dB

Note 1: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



3.3. LIST OF TEST AND MEASUREMENT INSTRUMENTS

3.3.1. For conducted emission at the mains terminals test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI	101417	Sep. 19, 2019
Artificial Mains Network	Rohde&Schwarz	L2-16B	000WX31025	Sep. 19, 2019
Artificial Mains Network	Rohde&Schwarz	ENV216	101342	Sep. 19, 2019

3.3.2. For radiated emission test (30MHz-1GHz)

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI	101417	Sep. 19, 2019
Bilog Antenna	SCHWARZBECK	VULB 9168	9168-572	Sep. 21, 2019
Preamplifier (low frequency)	SCHWARZBECK	BBV 9475	9745-0013	Sep. 19, 2019
Test S/W	Emtek		e3/1.0.0.0	do do do di

3.3.3. For radiated emission test (1GHz above)

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI	101417	Sep. 19, 2019
Spectrum Analyzer	Agilent	E4407B	MY45109572	Oct. 12, 2019
Horn Antenna	SCHWARZBECK	9120D	9120D-1246	Sep. 26, 2019
LOW NOISE AMPLIFIER	ZHINAN	ZN3380C	15002	Sep. 19, 2019
Test S/W	Emtek	1 1 1	e3/1.0.0.0	6 6 C



3.3.4. For harmonic current emissions and voltage fluctuations/flicker test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Harmonics / Flicker Test System	California Instruments	CTS/PACS-1-115	1534A00401	Sep. 19, 2019
AC Power Source	California Instruments	3001IX-208-CTS	1534A00401	Sep. 19, 2019
Test S/W	AMETEK	0 00 00 0	CTS 4	0 x 0 x 0

3.3.5. For electrostatic discharge immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
ESD Generator	SCHLODER	SESD216	606137	Dec. 14, 2019

3.3.6. For radio frequency electromagnetic field immunity (R/S) test (DQT)

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Signal Generator	Agilent	N517113-50B	MY53050160	Sep. 19, 2019
Amplifier	A&R	150W1000M3	313157	Sep. 19, 2019
Amplifier	A&R	50SIG6M2	0342835	Sep. 19, 2019
Antenna	SCHWARZBECK	STLP9149	9149.222	Sep. 19, 2019
Isotropic Field Probe	A&R	FL7006	0342652	Sep. 19, 2019
Log-periodic Antenna	SCHWARZBECK	STLP 9128E	9128E-012	Sep. 19, 2019

3.3.7. For electrical fast transient/burst immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EFT Tester	HTEC	HEFT 51	1416010	Sep. 19, 2019



EFT Coupling Clamp	HTEC	HEFT 51-C	1416011	Sep. 19, 2019
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3.3.8. For surge immunity test

Name of Equipment	Manufacturer	Model Serial N		Calibration Due
Surge Tester	HTEC	HCWG 71	174302	Sep. 19, 2019
Surge Tester	HTEC	TCOMB 4	142103	Sep. 19, 2019
Surge Tester	HTEC	HTSG 70	175002	Sep. 19, 2019

3.3.9. For injected currents susceptibility test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
C/S Test System	SCHLODER	CDG-6000-25	126A1279/2014	Sep. 19, 2019
Coupling Decoupling Network	SCHLODER	CDN-M2+3	A2210251/2013	Sep. 19, 2019
Electromagnetic Injection Clamp	Luthi	EM101	36041	Sep. 19, 2019
Test S/W	SCHLODER	6, 6, 6, 6	CDG/1.0.0.0	6, 6, 6,

3.3.10. For power frequency magnetic field immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Magnetic Field Tester	HTEC	HPFMF	142104	Sep. 19, 2019

3.3.11. For voltage dips and short interruptions immunity test

Name of Equipment Manufacturer Model Serial No.	Calibration Due
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Dips Tester	HTEC	HPFS	1416009	Sep. 19, 2019
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4. EUT DESCRIPTION

Product	Sound Level Meter	9	Q.	6	Q.	Q.	0	6	8	8
Model	HT622A,HT622B	\$1°C	\$1°C	& CO	\$1°C	61°C	\$1°	\$1°C	8X0	S.
Supplied Voltage	Battery	χO	XG.	20	χ0	χū	χG	χG	20	~
Power	N/A	Υ	Υ	Υ	Υ	Α.Ο.	Υ	Υ	Υ	Α

I/O PORT

I/O PORT TYPES	Q'TY	TESTED WITH
AC Port	10 10 10 10 10	40 40 Do 40 4
DC Port	x0 x0 10 x0 x0	20 20 X0 X

Models Difference

All samples are the same except model number.



5. TEST METHODOLOGY

5.1. TEST MODE

The EUT was tested together with the thereinafter additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The following test mode(s) were assessed.

	Test Items	Test Mode		
	Conducted Emission	N/A		
Emission	Radiated Emission	Working		
	Harmonic current emissions	N/A		
	Voltage fluctuations & flicker	N/A		
	ESD	Working		
	RS	Working		
	EFT	N/A		
Immunity	Surge	N/A		
	C/S	N/A		
	PFMF	N/A ZO ZO ZO		
	Dips	N/A		

5.2. EUT SYSTEM OPERATION

- 1. Set up EUT with the support equipment.
- 2. Make sure the EUT work normally during the test.



6. SETUP OF EQUIPMENT UNDER TEST

6.1. DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

No.	Equipment	Model	Serial No.	FCC ID	Trade Name	Data Cable	Power Cord
. 1.	N/A	N/A	N/A	N/A	N/A	N/A	N/A

Note: 1) All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

6.2. CONFIGURATION OF SYSTEM UNDER TEST

EUT

(EUT:Sound Level Meter)

Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



7. EMISSION TEST

7.1. CONDUCTED EMISSION MEASUREMENT

7.1.1. LIMITS

EDECHENCY	Cla	ss A	Class B		
FREQUENCY (MHz)	Quasi-peak dB(μV)	Average dB(μV)	Quasi-peak dB(μV)	Average dB(μV)	
0.15 - 0.5	79	66	66-56	56-46	
0.5 - 5.0	73	60	56	46	
5.0 - 30.0	73	. 60 .	60	50	

Note: 1) The lower limit shall apply at the transition frequencies.

2) The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

7.1.2. TEST PROCEDURES

The EUT and Support equipment, if needed, was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane, which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane. The EUT should be 0.8 m apart from the AMN, where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, Details please refer to test setup photography.

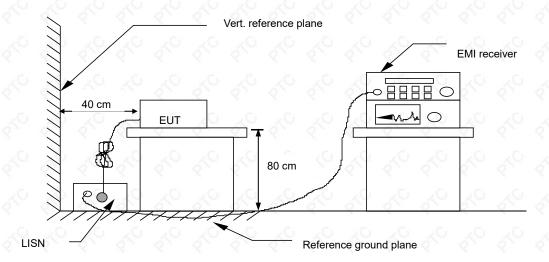
The Receiver scanned from 150 kHz to 30 MHz for emissions in each of the test modes. During the above scans, the emissions were maximized by cable manipulation.

A scan was taken on both of the power lines, Line and neutral, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. The test data of the worst-case condition(s) was recorded.

Note: Test Software Name: e3, Software Version: 1.0.0.0.



7.1.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.1.4. TEST RESULT

N/A



7.2. RADIATED EMISSION MEASUREMENT

7.2.1. LIMITS

FREQUENCY (MHz)	Class A(At 3m) Quasi-peak dB(μV/m)	Class B(At 3m) Quasi-peak dB(μV/m)
30 ~ 230	50	40
230 ~ 1000	57	47

Note: 1) The lower limit shall apply at the transition frequencies.

2) Emission level (dB μ V/m) = 20 log Emission level (μ V/m).

7.2.2. TEST PROCEDURE

The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane which has a 0.1 m non-conductive covering to insulate the EUT from the ground plane.

The antenna was placed at 3 meter away from the EUT. The antenna connected to the spectrum analyzer via a cable and at times a pre-amplifier would be used.

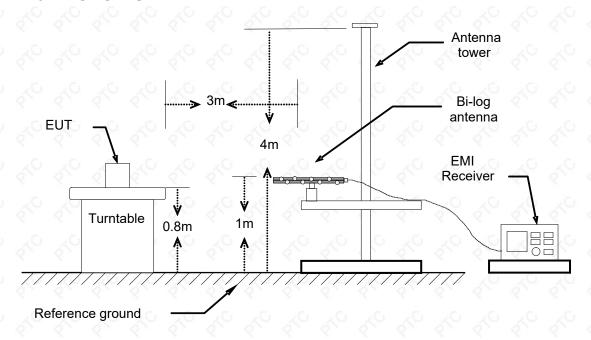
The analyzer / receiver quickly scanned from 30 MHz to 1000 MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

During the above scans, the emissions were maximized by cable manipulation. Each modes is measured, recorded at least the six highest emissions. The emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

The test data of the worst-case condition(s) was recorded. Note: Test Software Name: e3, Software Version: 8.2.1.0.



7.2.3. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration

7.2.4. TEST RESULT

Product name	Sound Level Meter	Antenna Distance	3 m
Model	HT622A	Antenna Pole	Vertical / Horizontal
Test Mode	Working	Detector Function	Quasi-peak
Environmental Conditions	24.3℃, 54.2 % RH, 101.3 kPa,	6 dB Bandwidth	120 kHz
Tested by	Yang	Test Result	Pass

Note:

Freq. = Emission frequency in MHz

Reading level ($dB\mu V$) = Receiver reading($dB\mu V$)

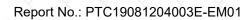
Corr.Factor (dB/m)=Antenna factor(dB/m)+Cable loss(dB)-Preamp Factor(dB)

Measurement (dB μ V/m)=Reading level(dB μ V)+ Corr. Factor (dB/m)

Limit ($dB\mu V/m$) = Limit stated in standard

Over Limit (dB) = Measurement (dB μ V/m) – Limit (dB μ V/m)

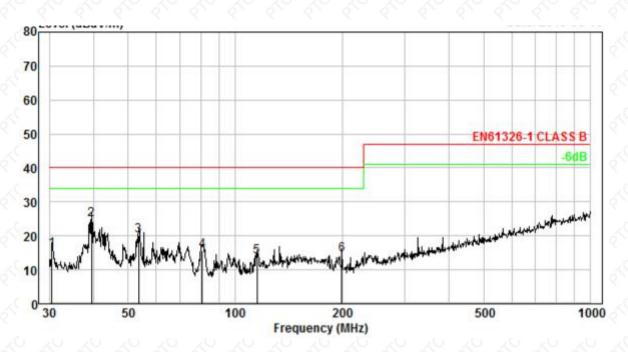
QP = Quasi-Peak





Please refer to the following diagram:

Vertical:

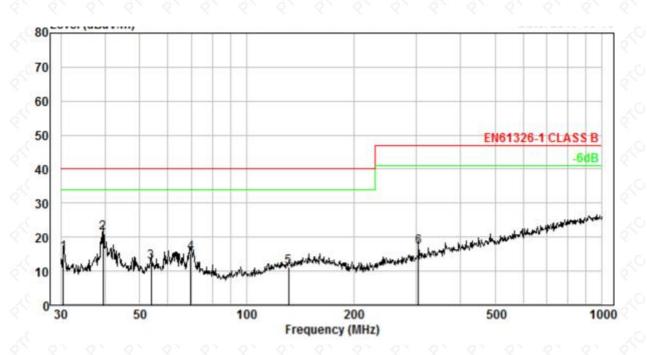


No.	Freq MHz	Cable Loss dB	ANT Factor dB/m	Receiver Reading dBuV	Preamp Factor dB	Emission Level dBuV/m	Limit dBuV/m	Over Limit dB	Remark
1.	30.531	1.23	13.24	31.42	29.98	15.91	40.00	-24.09	-QP
2.	39.437	1.68	13.67	39.54	30.07	24.82	40.00	-15.18	QP
3.	53.505	2.20	12.01	36.02	30.17	20.06	40.00	-19.94	QP
4.	80.927	2.91	8.75	34.19	30.32	15.53	40.00	-24.47	QP
5.	115.321	3.52	11.59	29.18	30.44	13.85	40.00	-26.15	QP
6.	199.286	4.45	10.43	30.07	30.63	14.32	40.00	-25.68	QP





Horizontal:



No.	Freq MHz	Cable Loss dB	ANT Factor dB/m	Receiver Reading dBuV	Preamp Factor dB	Emission Level dBuV/m	Limit dBuV/m	Over Limit dB	Remark	
1.	30.531	1.23	13.24	30.97	29.98	15.46	40.00	-24.54	QP	
2.	39.437	1.68	13.67	36.00	30.07	21.28	40.00	-18.72	QP	
3.	53.882	2.21	11.98	28.68	30.17	12.70	40.00	-27.30	QP	
4.	69.600	2.65	10.13	32.71	30.26	15.23	40.00	-24.77	QP	
5.	131.297	3.74	12.73	25.25	30.48	11.24	40.00	-28.76	QP	
6.	304.610	5.19	13.30	29.49	30.78	17.20	47.00	-29.80	QP	

7.3. HARMONICS CURRENT MEASUREMENT

7.3.1. LIMITS OF HARMONICS CURRENT MEASUREMENT

Limit for C	lass A equipment
Harmonics Order N	Max. permissible harmonics current A
Odd	harmonics
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15≦n≦39	0.15x(15/n)
4, 4,	4, 4, 4, 4,
Eve	n harmonics
4, 4,	4, 4, 4, 4,
2	1.08
4	0.43
, 6	0.30
8≤n≤40	0.23x8/n

KO KO KI	Limit for Class D equip	pment
Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
	Odd Harmonics on	ly of or or
3	3.4	2.30
5	1.9	1.14
. 7 _.	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13	0.30	0.21
15≦n≦39 (odd harmonics only)	3.85/n	0.15x(15/n)
	<u> </u>	10 10 10 10 10 10 10 10 10 10 10 10 10 1
10 10 10	<u> </u>	4° 4° 4° 4°

Limit for Class C equipment						
Harmonics Order n	Max. permissible harmonics current expressed as a percentage of the input current at the fundamental frequency A					
2	2					
3 3	30xF					
5	10					
6 6 6 75 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6	10 10 10 10 10 10 10 10 10 10 10 10 10 1					
9	5					
11≦n<≦39 (odd harmonics only)	40 40 40 40 40 40 40 40 40 40 40 40 40 4					
F is the circuit power factor	to					

Note: Class A, B, C and D are classified according to item 7.3.2.of this report

7.3.2. TEST PROCEDURES

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce



the maximum harmonic. The classification of EUT is according to section 5 of EN 61000-3-2.

The EUT is classified as follows:

Class A:

Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B:

Portable tools; Arc welding equipment which is not professional equipment.

Class C:

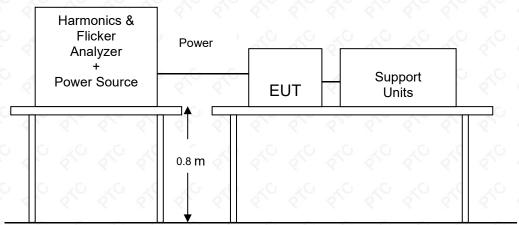
Lighting equipment

Class D:

Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors and television receivers.

The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

7.3.3. TEST SETUP



For the actual test configuration, please refer to the related item- Photographs of the Test Configuration.

7.3.4. TEST RESULT

N/A



7.4. VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

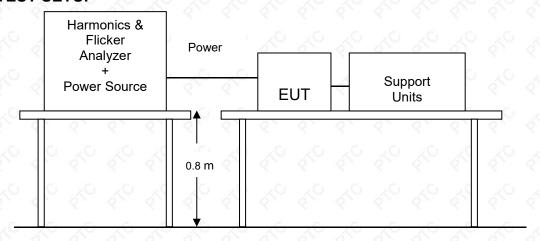
7.4.1. LIMITS OF VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

TEST ITEM LIMIT		REMARK	
P _{st}	1.0	P _{st} means short-term flicker indicator.	
?` ?`P _{It} ?` ?`	0.65	P _{lt} means long-term flicker indicator.	
T _{dt} (ms)	500	T _{dt} means maximum time that dt exceeds 3 %.	
d _{max} (%)	4/6/7 %	d _{max} means maximum relative voltage chan	
dc (%)	3.3 %	dc means relative steady-state voltage change	

7.4.2. TEST PROCEDURE

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under full load operating conditions. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

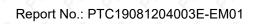
7.4.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.4.4. TEST RESULT

N/A

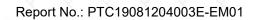




8. IMMUNITY TEST

8.1. GENERAL DESCRIPTION

Due deset Oters de ad		EN 61326-1			
Product Standard	Test Type	Minimum Requirement			
	EN 61000-4-2	Electrostatic Discharge – ESD: ±8 kV air discharge, ±4 kV Contact discharge, Performance Criterion B			
	EN 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 3V/m (80MHz to 1GHz) 3V/m (1.4GHz to 2GHz) 1V/m (2.0GHz to 2.7GHz) Performance Criterion A			
	EN 61000-4-4	Electrical Fast Transient/Burst - EFT, Power line: ±1 kV (5/50ns, 5kHz) Performance Criterion B			
Basic Standard, Specification, and Performance	EN 61000-4-5	Surge Immunity Test: 1.2/50 µs Open Circuit Voltage, 8 /20 µs Short Circuit Current, Power Port ~ Line to line: ±1 kV, Performance Criterion B			
Criterion required	EN 61000-4-6	Conducted Radio Frequency Disturbances Test –CS: 0.15 ~ 80 MHz, 3 V r.m.s, 80 % AM, 1 kHz, Performance Criterion A			
	EN 61000-4-8	Power frequency magnetic field immunity test 50 Hz, 3 A/m Performance Criterion A			
	EN 61000-4-11	Voltage Dips: i) 0% during for 0.5 cycle, Performance Criterion B ii) 40% during for 1 cycles, Performance Criterion B ii) 70% during for 25/30 cycles, Performance Criterion C Short Interruptions: 0% during for 250/300 cycles, Performance Criterion C			





8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION

U.Z. OLIV	ENALT EN ONMANGE CHITENIA DESCRITTION
Criteria A:	During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a minimum performance level specified by the manufacturer when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.
Criteria B:	After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.
Criteria C:	During and after testing, a temporary loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls or cycling of the power to the EUT by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



8.3. ELECTROSTATIC DISCHARGE (ESD)

8.3.1. TEST SPECIFICATION

Basic Standard: EN 61000-4-2

Discharge Impedance:330 ΩCharging Capacity:150 pF

Discharge Voltage:

Air Discharge: ±8 kV (Direct)

Contact Discharge: ± 4 kV (Direct/Indirect)

Polarity: Positive & Negative

Number of Discharge: 10

Discharge Mode: 1 time/s

Performance Criterion:

8.3.2. TEST PROCEDURE

The discharges shall be applied in two ways:

- a) Contact discharges to the conductive surfaces and coupling planes: 50 dischargers (10 times positive and 10 times negative polarity) shall be applied on each accessible metallic part of the enclosure, terminals are excluded. In case of a non-conductive enclosure, dischargers shall be applied on the horizontal or vertical coupling planes. Test shall be performed at a maximum repetition rate of one discharge per second.
- b) Air discharges at slots and apertures and insulating surfaces: On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

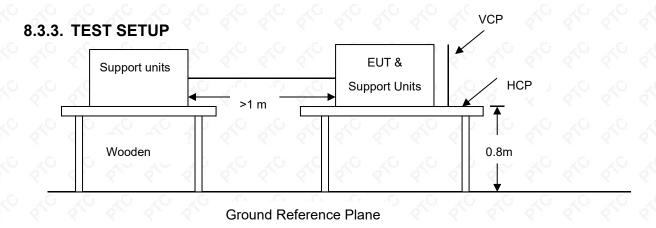
The basic test procedure was in accordance with IEC 61000-4-2:

- a) The EUT was located 0.1 m minimum from all side of the HCP (dimensions 1.6 m x 0.8 m).
- b) The support units were located another table 30 cm away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10cm with EUT.
- c) The time interval between two successive single discharges was at least 1 second.



- d) Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- e) Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- f) At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1 meter from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.
- g) At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane (VCP) in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5 m x 0.5 m) was placed vertically to and 0.1 meter from the EUT.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Note:

1) TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the ground reference plane (GRP) . The GRP consisted of a sheet of aluminum at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system. A horizontal coupling plane (HCP) (1.6 m x 0.8 m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5 mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

2) FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the ground reference plane by an insulating support of 0.1 meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



8.3.4. TEST RESULT

Product	Sound Level Meter	Environmental Conditions	24.3℃, 54.2 % RH, 101.3 kPa,
Model	HT622A	Tested By	Yang
Test mode	Working	Test Result	Pass

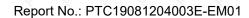
	Air Discharge					
		Test Levels Results				
	Test Points	± 8 kV	Pass	Fail	Observation	Performance Criterion
ſ	Slot 4 Points		\boxtimes		Note ☐ 1 ⊠ 2 ☐ 3	В
	Button 2 Points				Note ☐ 1 ⊠ 2 ☐ 3	В

Contact Discharge						
	Test Levels			Results		
Test Points	± 4 kV	Pass	Fail	Observation	Performance Criterion	
HCP 4 Points				Note ☐ 1⊠2☐ 3	В	
VCP 4 Points		\boxtimes		Note ☐ 1⊠2☐ 3	В	

Note: 1) There was no change compared with initial operation during the test.

²⁾ During the test the luminous intensity change, and after the test the luminous intensity can be restored to its initial value within 1 min.

³⁾ During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.





8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)

8.4.1. TEST SPECIFICATION

Basic Standard: EN 61000-4-3

80MHz to 1GHz

Frequency Range: 1.4GHz to 2GHz

2.0GHz to 2.7GHz

3V/m

Field Strength: 3V/m

1V/m

Modulation: 1 kHz Sine Wave, 80 %, AM Modulation

Frequency Step: 1 % of preceding frequency value

Polarity of Antenna: Horizontal and Vertical

Test Distance: 3 m
Antenna Height: 1.5 m
Performance Criterion: A

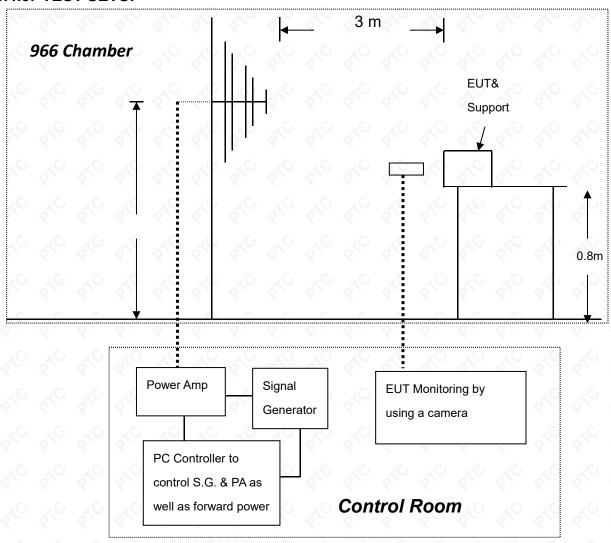
8.4.2. TEST PROCEDURE

The test procedure was in accordance with EN 61000-4-3

- a) The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
 - b) The frequency range is swept from 80MHz to 1GHz, 1.4GHz to 2GHz,
 - 2.0GHz to 2.7GHz, with the signal 80% amplitude modulated with a 1 kHz sine-wave. The rate of sweep did not exceed 1.5 x 10 $^{-3}$ decade/s, where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value.
- c) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



8.4.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Note:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



8.4.4. TEST RESULT

Product	Sound Level Meter	Environmental Conditions	24.3℃, 54.2 % RH, 101.3 kPa,
Model	HT622A	Tested By	Yang
Test mode	Working	Test Result	Pass

Frequency (MHz)	Polarity	Position	Field Strength (V/m)	Observation	Performance Criterion
80-1000	V&H	Front, Rear, Left, Right	3	Note ⊠ 1 □ 2 □ 3	_ A
1400-2000	V&H	Front, Rear, Left, Right	3	Note ⊠1 □2 □3	_ A
2000-2700	V&H	Front, Rear, Left, Right	0 10	Note ⊠1 □2 □3	o CA

Note: 1) There was no change compared with initial operation during the test.

²⁾ During the test the luminous intensity change ,and after the test the luminous intensity can be restored to its initial value within 1 min.

³⁾ During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



8.5. ELECTRICAL FAST TRANSIENT (EFT)

8.5.1. TEST SPECIFICATION

Basic Standard: EN 61000-4-4

Test Voltage: Power Line: ±1 kV **Polarity:** Positive & Negative

Impulse Frequency:5 kHzImpulse Wave-shape:5/50 nsBurst Duration:15 msBurst Period:300 msTest Duration:2 mins

Performance Criterion: B

8.5.2. TEST PROCEDURE

EUT is placed on a 0.8 m tall wooden table.

EUT operate at normal mode, the transient/burst was 5/50 ns in accordance with EN 61000-4-4, both positive and negative polarity burst waveform were applied.

The duration time of each test line was 2 minutes.

8.5.3. TEST SETUP

The EUT installed in a representative system as described in section 7 of EN 61000-4-4.

For the actual test configuration, please refer to the related item – photographs of the test configuration.

8.5.4. TEST RESULT

N/A



8.6. SURGE IMMUNITY TEST

8.6.1. TEST SPECIFICATION

Basic Standard: EN 61000-4-5

Combination Wave

Wave-Shape: 1.2/50 μs Open Circuit Voltage

8/20 µs Short Circuit Current

Test Voltage: Power Port ~ Line to line: ±1 kV

Surge Input/Output: Power Line: L-N

Generator Source Impedance: 2Ω between networks

12 Ω between network and ground

Polarity: Positive/Negative

Phase Angle: 0° /90° /180° /270°

Pulse Repetition Rate: 1 time / min

Number of Tests: 5 positive polarity pulses, and 5 negative polarity pulses

Performance Criterion: B

8.6.2. TEST PROCEDURE

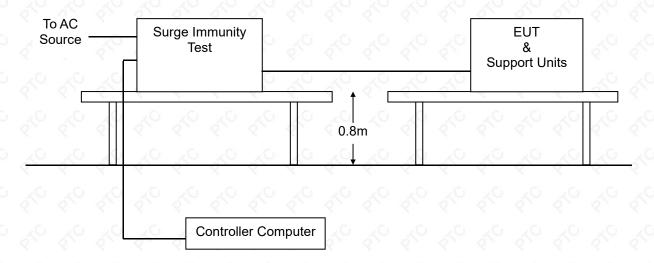
EUT is placed on a 0.8 m tall wooden table.

EUT operate at normal mode, two types of combination wave generator (1.2/50 us open-circuit voltage and 8/20 us short-circuit current) are applied to the EUT power supply terminals via the capacitive coupling network.

The power cord between the EUT and the coupling/decoupling network shall not exceed 2 m in length.



8.6.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.6.4. TEST RESULT

N/A



8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

8.7.1. TEST SPECIFICATION

Basic Standard: EN 61000-4-6

Frequency Range: 0.15 MHz ~80 MHz

Field Strength: 3 V

Modulation: 1 kHz Sine Wave, 80 %, AM Modulation

Frequency Step: 1 % of preceding frequency value

Coupled cable: Power Mains, Shielded

Coupling device: CDN-M3/2 (3 wires/2 wires)

Performance Criterion: A

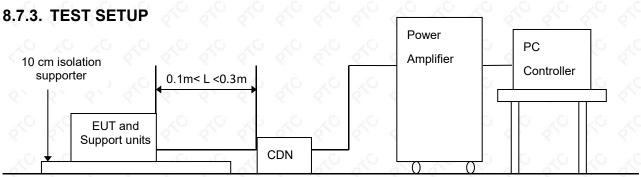
8.7.2. TEST PROCEDURE

The EUT shall be tested within its intended operating and climatic conditions.

The test shall performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50 Ω load resistor.

The frequency range was swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was 1.5×10^{-3} decades/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value the dwell time of the amplitude modulated carrier at each frequency was 0.5×10^{-3} decades.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration Note: 1) The EUT is setup 0.1 m above Ground Reference Plane

2) All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

8.7.4. TEST RESULT

N/A



8.8. POWER FREQUENCY MAGNETIC FIELD

8.8.1. TEST SPECIFICATION

Basic Standard: EN 61000-4-8

Frequency Range: 50 Hz
Field Strength: 3 A/m

Observation Time: 5 minutes

Inductance Coil: Rectangular type, 1 m x 1 m

Performance Criterion: A

8.8.2. TEST PROCEDURE

The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1 m-thick insulating support.

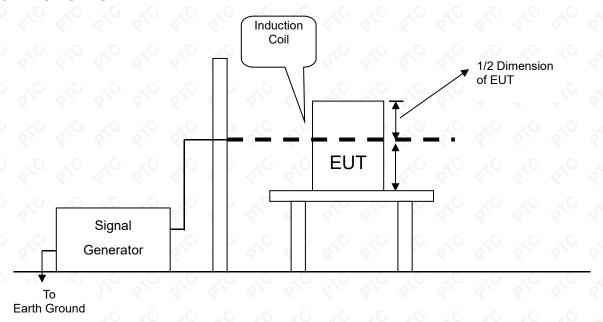
The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.

The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.

The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



8.8.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration Note:

TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

8.8.4. TEST RESULT

N/A



8.9. VOLTAGE DIP & VOLTAGE INTERRUPTIONS

8.9.1. TEST SPECIFICATION

Basic Standard: EN 61000-4-11

Test Duration Time: 3 test events in sequence

Interval Between Event: 10 seconds

Phase Angle: 0°

Test Cycle: 3 times

Performance Criterion:

i) 0% during for 0.5 cycle,
Performance Criterion B

ii) 40% during for 1 cycles, Performance Criterion Bii) 70% during for 25/30 cycles, Performance Criterion C

Short Interruptions:

0% during for 250/300 cycles, Performance Criterion C

8.9.2. TEST PROCEDURE

The EUT and support units were located on a wooden table, 0.8 m away from ground floor.

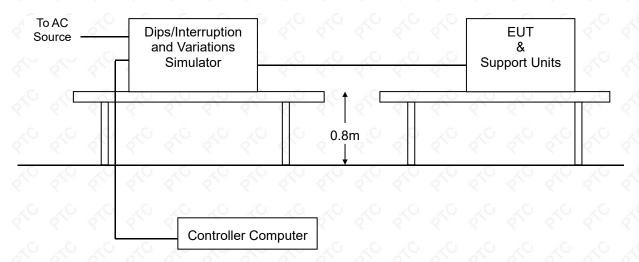
Setting the parameter of tests and then perform the test software of test simulator.

Changes to the voltage level shall occur at 0 degree crossing point in the a.c. voltage waveform.

Record the test result in test record form.



8.9.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.9.4. TEST RESULT

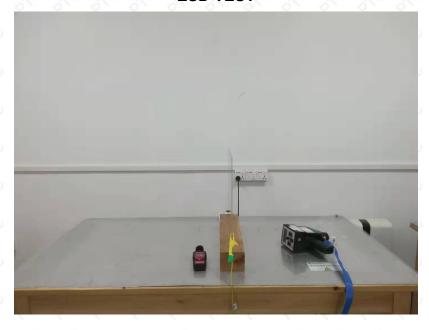
N/A

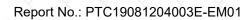


9. PHOTOGRAPHS OF THE TEST CONFIGURATION RADIATED EMISSION TEST

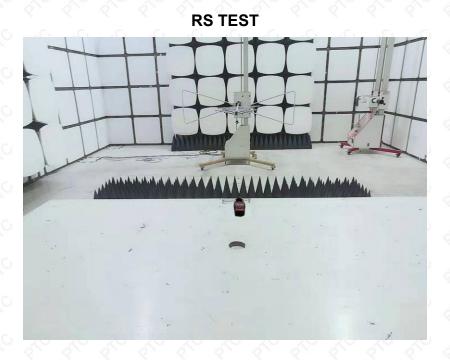


ESD TEST







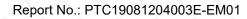




10. PHOTOGRAPHS OF EUT











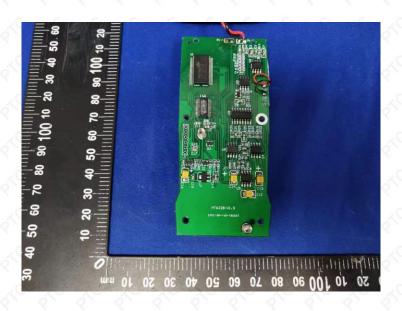


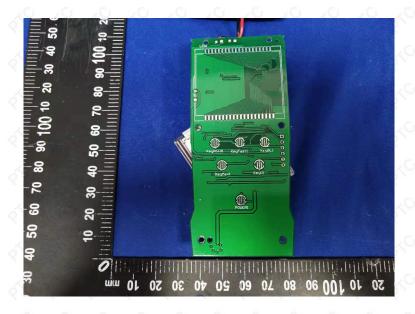












— End of report —